

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
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	Examiner Kwiecinski, Ryan D	Art Unit 3635

SEARCHED

Class	Subclass	Date	Examiner
52	204.1	3/14/2007	RDK
	455	3/14/2007	RDK
	475.1	3/14/2007	RDK
	479	3/14/2007	RDK
	783.1	3/14/2007	RDK
	784.1	3/14/2007	RDK
	455	3/14/2007	RDK
	456	3/14/2007	RDK

SEARCH NOTES

Search Notes	Date	Examiner
Class 52 Search	3/14/2007	RDK
IDS (Forward and Backward Citations)	3/14/2007	RDK
BRS Text Search (See attached)	3/14/2007	RDK
PALM Inventor Search	3/14/2007	RDK

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner